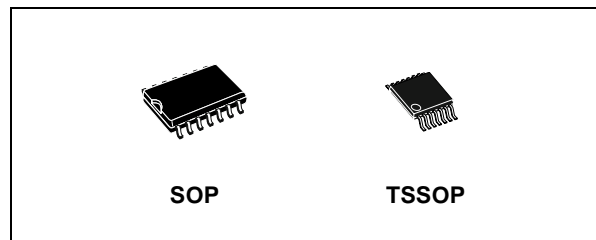


## DUAL D-TYPE FLIP FLOP WITH PRESET AND CLEAR

- HIGH SPEED:  
 $f_{MAX} = 250 \text{ MHz (TYP.) at } V_{CC} = 3.3\text{V}$
- COMPATIBLE WITH TTL OUTPUTS
- LOW POWER DISSIPATION:  
 $I_{CC} = 2 \mu\text{A (MAX.) at } T_A = 25^\circ\text{C}$
- LOW NOISE:  
 $V_{OLP} = 0.2 \text{ V (TYP.) at } V_{CC} = 3.3\text{V}$
- 75Ω TRANSMISSION LINE DRIVING CAPABILITY
- SYMMETRICAL OUTPUT IMPEDANCE:  
 $|I_{OH}| = I_{OL} = 12\text{mA (MIN) at } V_{CC} = 3.0\text{V}$
- PCI BUS LEVELS GUARANTEED AT 24 mA
- BALANCED PROPAGATION DELAYS:  
 $t_{PLH} \approx t_{PHL}$
- OPERATING VOLTAGE RANGE:  
 $V_{CC(OPR)} = 2\text{V to } 3.6\text{V (1.2V Data Retention)}$
- PIN AND FUNCTION COMPATIBLE WITH 74 SERIES 74
- IMPROVED LATCH-UP IMMUNITY

### DESCRIPTION

The 74LVQ74 is a low voltage CMOS DUAL D-TYPE FLIP FLOP WITH PRESET AND CLEAR NON INVERTING fabricated with sub-micron silicon gate and double-layer metal wiring C<sup>2</sup>MOS



**Table 1: Order Codes**

PACKAGE	T & R
SOP	74LVQ74MTR
TSSOP	74LVQ74TTR

technology. It is ideal for low power and low noise 3.3V applications.

A signal on the D INPUT is transferred to the Q OUTPUT during the positive going transition of the clock pulse.

CLEAR and PRESET are independent of the clock and accomplished by a low setting on the appropriate input.

All inputs and outputs are equipped with protection circuits against static discharge, giving them 2KV ESD immunity and transient excess voltage.

**Figure 1: Pin Connection And IEC Logic Symbols**

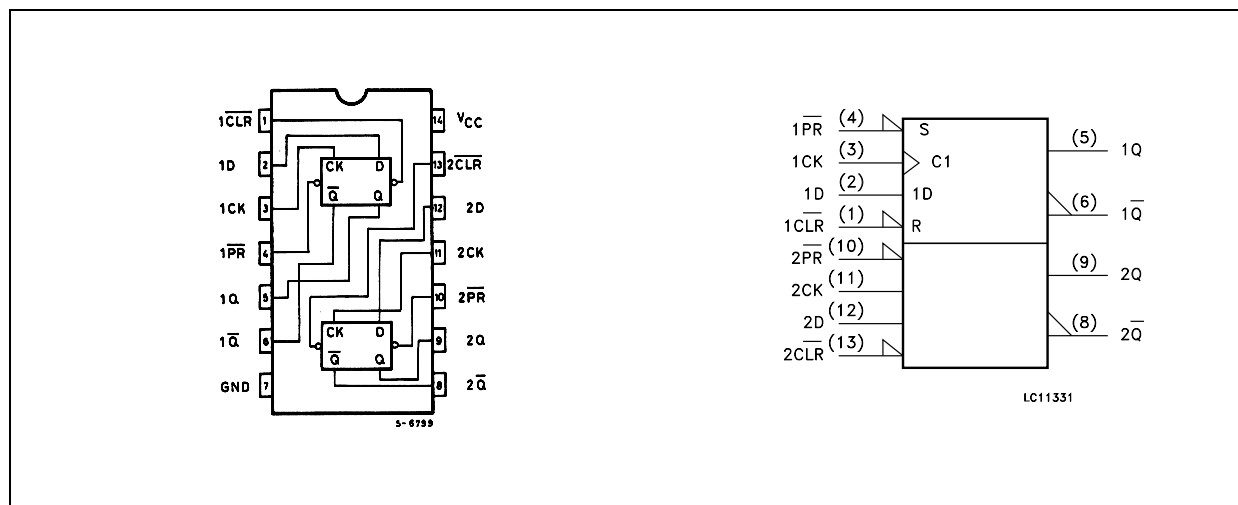


Figure 2: Input And Output Equivalent Circuit

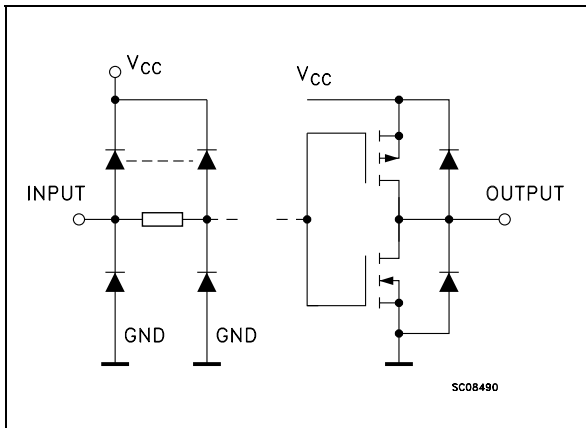


Table 2: Pin Description

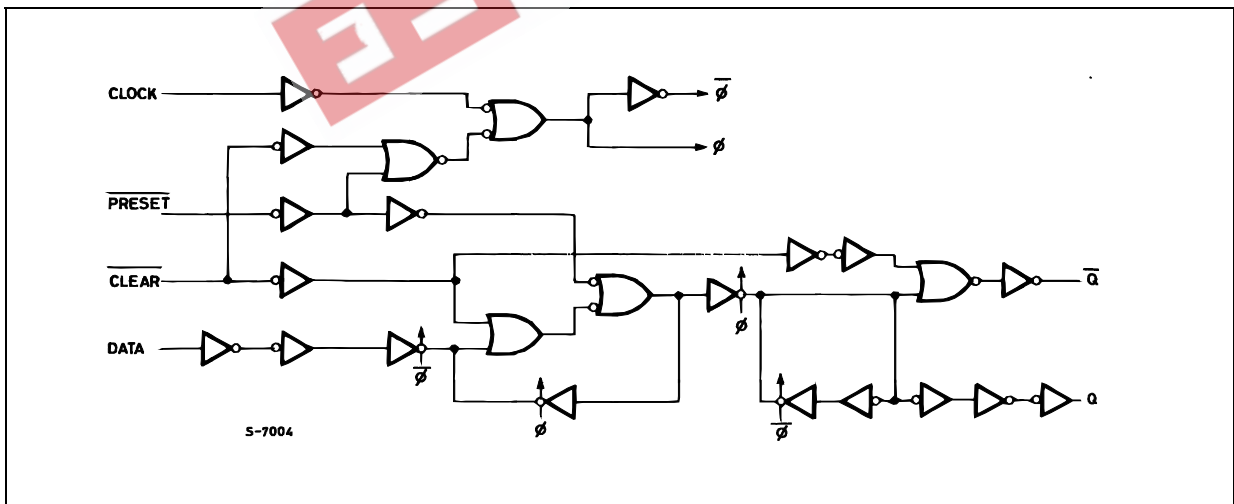
PIN N°	SYMBOL	NAME AND FUNCTION
1, 13	$\overline{1CLR}, \overline{2CLR}$	Asynchronous Reset - Direct Input
2, 12	1D, 2D	Data Inputs
3, 11	1CK, 2CK	Clock Input (LOW to HIGH, Edge Triggered)
4, 10	$\overline{1PR}, \overline{2PR}$	Asynchronous Set - Direct Input
5, 9	1Q, 2Q	True Flip-Flop Outputs
6, 8	$\overline{1Q}, \overline{2Q}$	Complement Flip-Flop Outputs
7	GND	Ground (0V)
14	V <sub>CC</sub>	Positive Supply Voltage

Table 3: Truth Table

INPUTS				OUTPUTS		FUNCTION
$\overline{CLR}$	$\overline{PR}$	D	CK	Q	$\overline{Q}$	
L	H	X	X	L	H	CLEAR
H	L	X	X	H	L	PRESET
L	L	X	X	H	H	
H	H	L	$\downarrow$	L	H	
H	H	H	$\downarrow$	H	L	
H	H	X	$\downarrow$	Q <sub>n</sub>	$\overline{Q}_n$	NO CHANGE

X : Don't Care

Figure 3: Logic Diagram



This logic diagram has not be used to estimate propagation delays

Table 4: Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply Voltage	-0.5 to +7	V
$V_I$	DC Input Voltage	-0.5 to $V_{CC} + 0.5$	V
$V_O$	DC Output Voltage	-0.5 to $V_{CC} + 0.5$	V
$I_{IK}$	DC Input Diode Current	$\pm 20$	mA
$I_{OK}$	DC Output Diode Current	$\pm 20$	mA
$I_O$	DC Output Current	$\pm 50$	mA
$I_{CC}$ or $I_{GND}$	DC $V_{CC}$ or Ground Current	$\pm 400$	mA
$T_{stg}$	Storage Temperature	-65 to +150	°C
$T_L$	Lead Temperature (10 sec)	300	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied

Table 5: Recommended Operating Conditions

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply Voltage (note 1)	2 to 3.6	V
$V_I$	Input Voltage	0 to $V_{CC}$	V
$V_O$	Output Voltage	0 to $V_{CC}$	V
$T_{op}$	Operating Temperature	-55 to 125	°C
dt/dv	Input Rise and Fall Time $V_{CC} = 3.0V$ (note 2)	0 to 10	ns/V

1) Truth Table guaranteed: 1.2V to 3.6V

2)  $V_{IN}$  from 0.8V to 2V

Table 6: DC Specifications

Symbol	Parameter	Test Condition $V_{CC}$ (V)	Value								Unit
			$T_A = 25^\circ C$			-40 to 85°C		-55 to 125°C			
			Min.	Typ.	Max.	Min.	Max.	Min.	Max.		
$V_{IH}$	High Level Input Voltage	3.0 to 3.6	2.0			2.0		2.0		V	
$V_{IL}$	Low Level Input Voltage	3.0 to 3.6			0.8		0.8		0.8	V	
$V_{OH}$	High Level Output Voltage	3.0	$I_O = -50 \mu A$	2.9	2.99		2.9		2.9		V
			$I_O = -12 mA$	2.58			2.48		2.48		
			$I_O = -24 mA$				2.2		2.2		
$V_{OL}$	Low Level Output Voltage	3.0	$I_O = 50 \mu A$		0.002	0.1		0.1		0.1	V
			$I_O = 12 mA$		0	0.36		0.44		0.44	
			$I_O = 24 mA$				0.55		0.55		
$I_I$	Input Leakage Current	3.6	$V_I = V_{CC}$ or GND			$\pm 0.1$		$\pm 1$		$\pm 1$	$\mu A$
$I_{CC}$	Quiescent Supply Current	3.6	$V_I = V_{CC}$ or GND			2		20		20	$\mu A$
$I_{OLD}$	Dynamic Output Current (note 1, 2)	3.6	$V_{OLD} = 0.8 V$ max					36		25	mA
$I_{OHD}$			$V_{OHD} = 2 V$ min				-25		-25		mA

1) Maximum test duration 2ms, one output loaded at time

2) Incident wave switching is guaranteed on transmission lines with impedances as low as 75 $\Omega$

Table 7: Dynamic Switching Characteristics

Symbol	Parameter	Test Condition		Value						Unit	
		V <sub>CC</sub> (V)		T <sub>A</sub> = 25°C			-40 to 85°C		-55 to 125°C		
				Min.	Typ.	Max.	Min.	Max.	Min.		Max.
V <sub>OLP</sub>	Dynamic Low Voltage Quiet Output (note 1, 2)	3.3	C <sub>L</sub> = 50 pF		0.2	0.8					V
V <sub>OLV</sub>				-0.8	-0.2						
V <sub>IHD</sub>	Dynamic High Voltage Input (note 1, 3)	3.3		2							V
V <sub>ILD</sub>	Dynamic Low Voltage Input (note 1, 3)	3.3				0.8					V

1) Worst case package.

2) Max number of outputs defined as (n). Data inputs are driven 0V to 3.3V, (n-1) outputs switching and one output at GND.

3) Max number of data inputs (n) switching. (n-1) switching 0V to 3.3V. Inputs under test switching: 3.3V to threshold (V<sub>ILD</sub>), 0V to threshold (V<sub>IHD</sub>), f=1MHz.

Table 8: AC Electrical Characteristics (C<sub>L</sub> = 50 pF, R<sub>L</sub> = 500 Ω, Input t<sub>r</sub> = t<sub>f</sub> = 3ns)

Symbol	Parameter	Test Condition		Value						Unit	
		V <sub>CC</sub> (V)		T <sub>A</sub> = 25°C			-40 to 85°C		-55 to 125°C		
				Min.	Typ.	Max.	Min.	Max.	Min.		Max.
t <sub>PLH</sub>	Propagation Delay Time CK to Q	2.7			7.7	12.0		14.0		16.0	ns
t <sub>PHL</sub>		3.3(*)		6.3	9.0		10.5		12.0		
t <sub>PLH</sub>	Propagation Delay Time PR or CLR to Q	2.7		6.9	12.0		14.0		16.0	ns	
t <sub>PHL</sub>		3.3(*)		5.8	9.0		10.5		12.0		
t <sub>w</sub>	Pulse Width CK, HIGH or LOW	2.7	4.0	1.5		4.0		5.0	ns		
		3.3(*)	3.0	1.5		3.0		4.0			
t <sub>w(L)</sub>	Pulse Width PR or CLR, LOW	2.7	4.0	1.5		4.0		5.0	ns		
		3.3(*)	3.0	1.5		3.0		4.0			
t <sub>s</sub>	Setup Time D to CK HIGH or LOW	2.7	4.0	-0.2		4.0		5.0	ns		
		3.3(*)	3.0	-0.2		3.0		4.0			
t <sub>h</sub>	Hold Time D to CK HIGH or LOW	2.7	2.0	0.2		2.0		2.0	ns		
		3.3(*)	2.0	0.2		2.0		2.0			
t <sub>REM</sub>	Recovery Time PR or CLR to Q	2.7	1.0	-1.0		1.0		1.0	ns		
		3.3(*)	1.0	-1.0		1.0		1.0			
f <sub>MAX</sub>	Maximum Clock Frequency	2.7	100	200		100		80	MHz		
		3.3(*)	120	250		120		100			
t <sub>OSLH</sub>	Output To Output Skew Time (note1, 2)	2.7		0.2	1.0		1.0		1.0	ns	
t <sub>OSHL</sub>		3.3(*)		0.2	1.0		1.0		1.0		

1) Skew is defined as the absolute value of the difference between the actual propagation delay for any two outputs of the same device switching in the same direction, either HIGH or LOW (t<sub>OSLH</sub> = |t<sub>PLHm</sub> - t<sub>PLHn</sub>|, t<sub>OSHL</sub> = |t<sub>PHLm</sub> - t<sub>PHLn</sub>|)

2) Parameter guaranteed by design

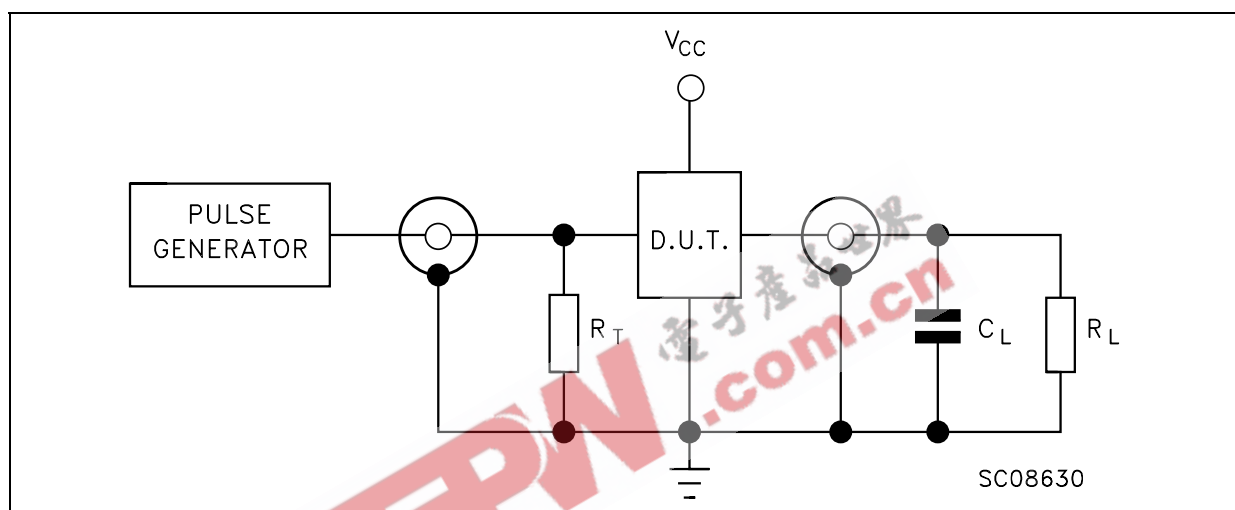
(\*) Voltage range is 3.3V ± 0.3V

Table 9: Capacitive Characteristics

Symbol	Parameter	Test Condition		Value						Unit	
		V <sub>CC</sub> (V)		T <sub>A</sub> = 25°C			-40 to 85°C		-55 to 125°C		
				Min.	Typ.	Max.	Min.	Max.	Min.		Max.
C <sub>IN</sub>	Input Capacitance	3.3			4						pF
C <sub>PD</sub>	Power Dissipation Capacitance (note 1)	3.3	f <sub>IN</sub> = 10MHz		33						pF

1) C<sub>PD</sub> is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit). Average operating current can be obtained by the following equation.  $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}/n$  (per circuit)

Figure 4: Test Circuit



C<sub>L</sub> = 50pF or equivalent (includes jig and probe capacitance)  
R<sub>L</sub> = 500Ω or equivalent  
R<sub>T</sub> = Z<sub>OUT</sub> of pulse generator (typically 50Ω)

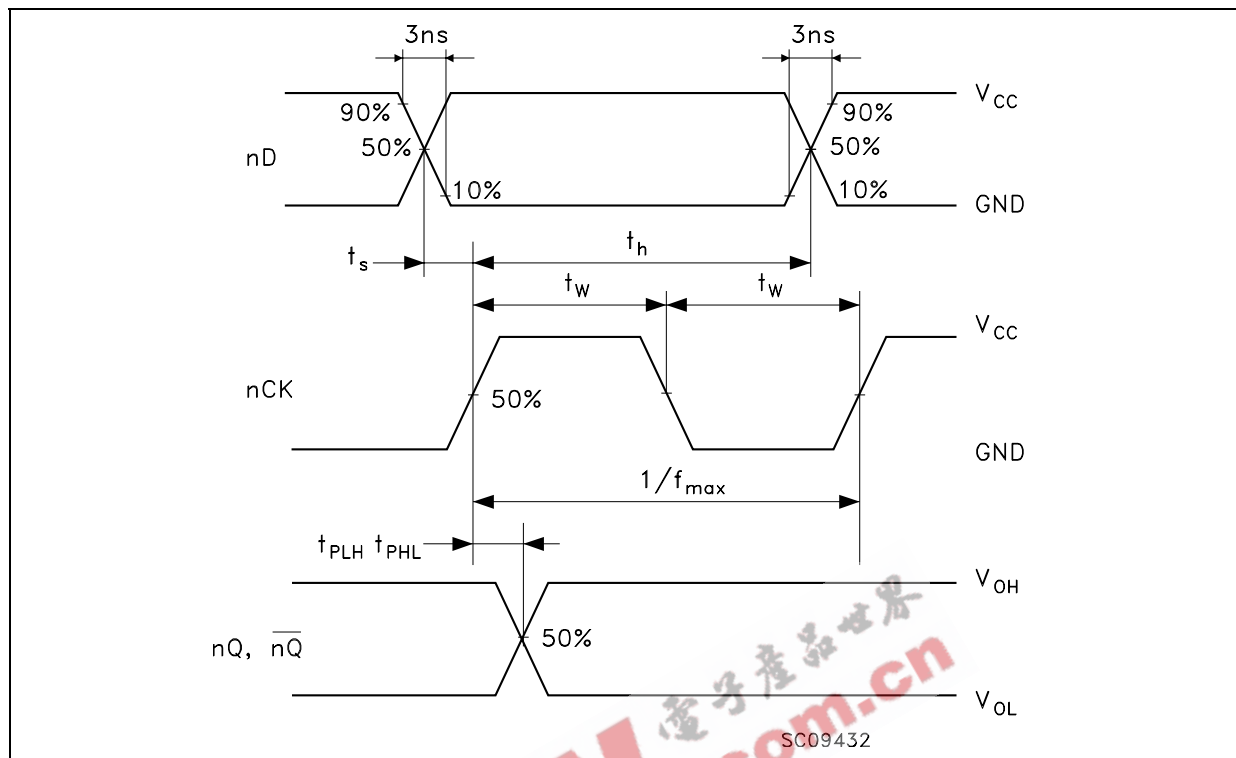
Figure 5: Waveform - Propagation Delays, Setup And Hold Times ( $f=1\text{MHz}$ ; 50% duty cycle)

Figure 6: Waveform - Propagation Delays (f=1MHz; 50% duty cycle)

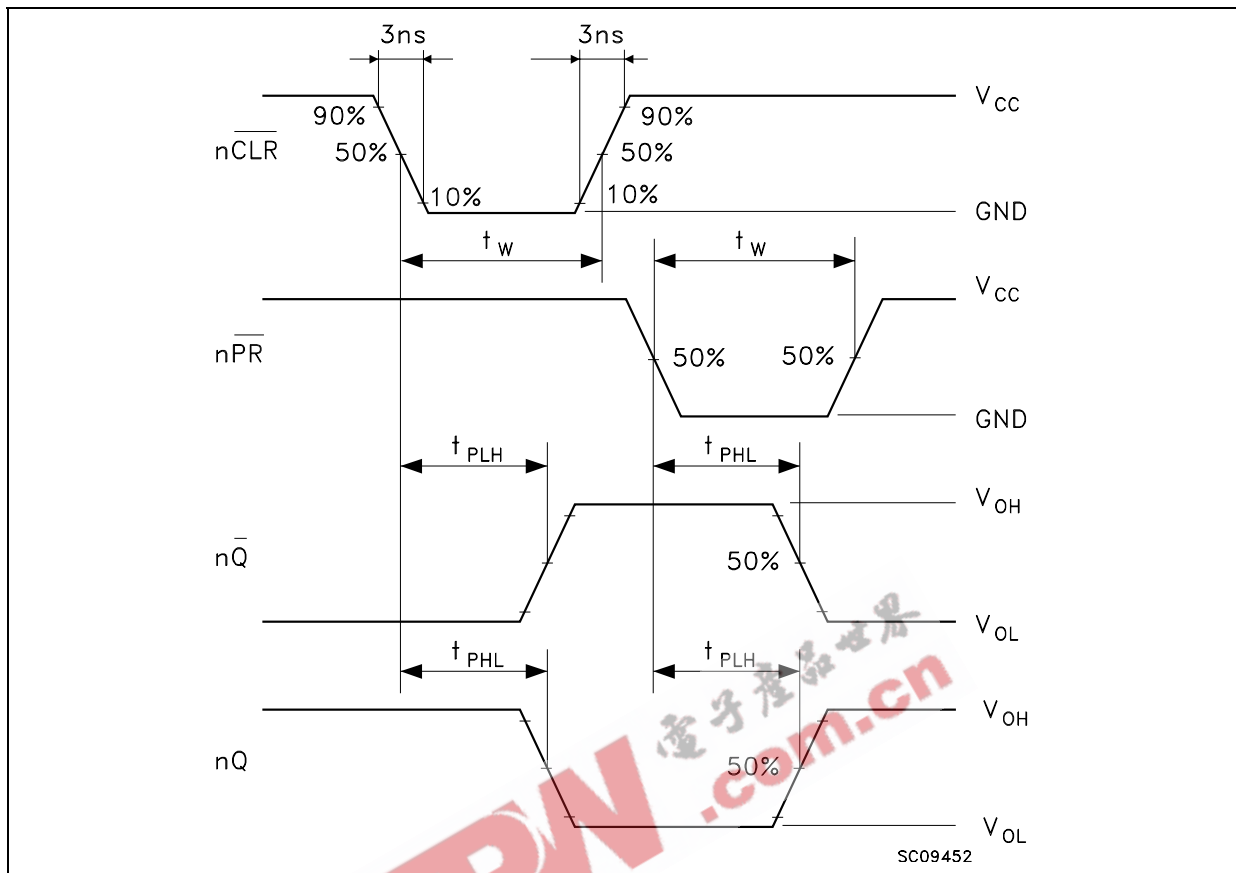
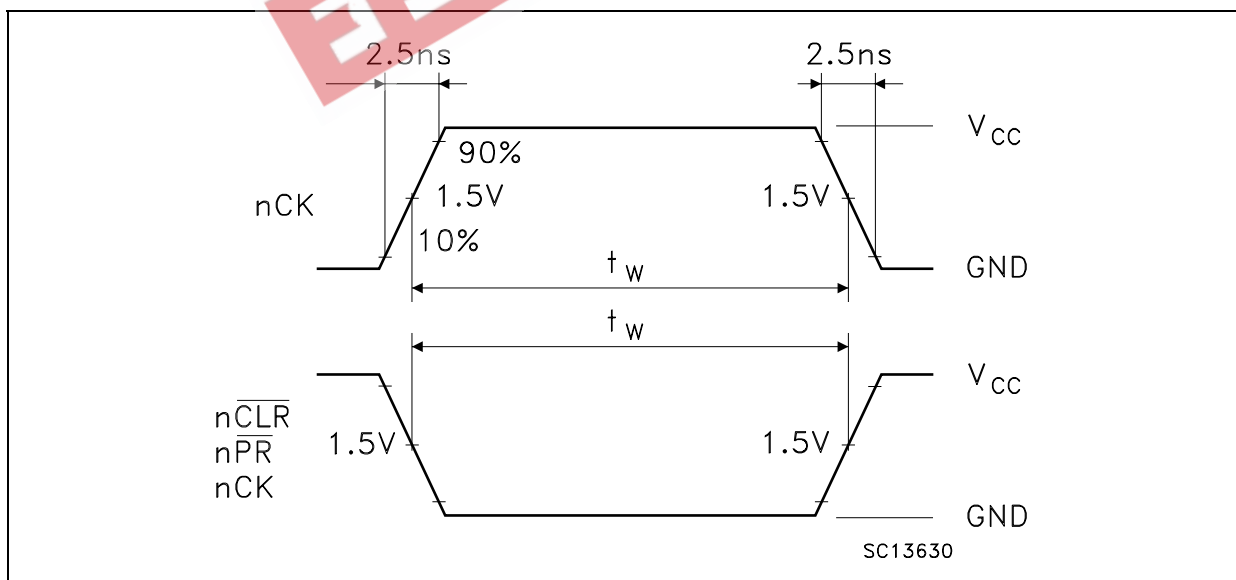
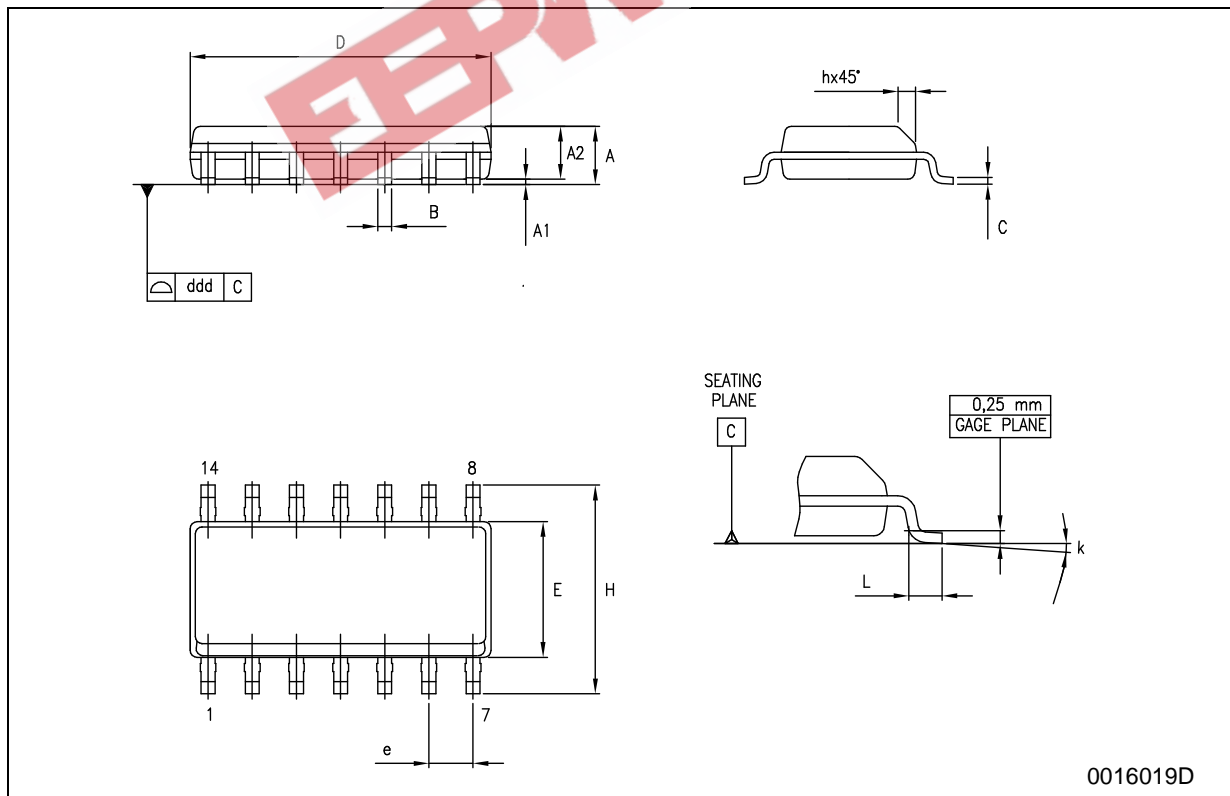


Figure 7: Waveform - Pulse Width



## SO-14 MECHANICAL DATA

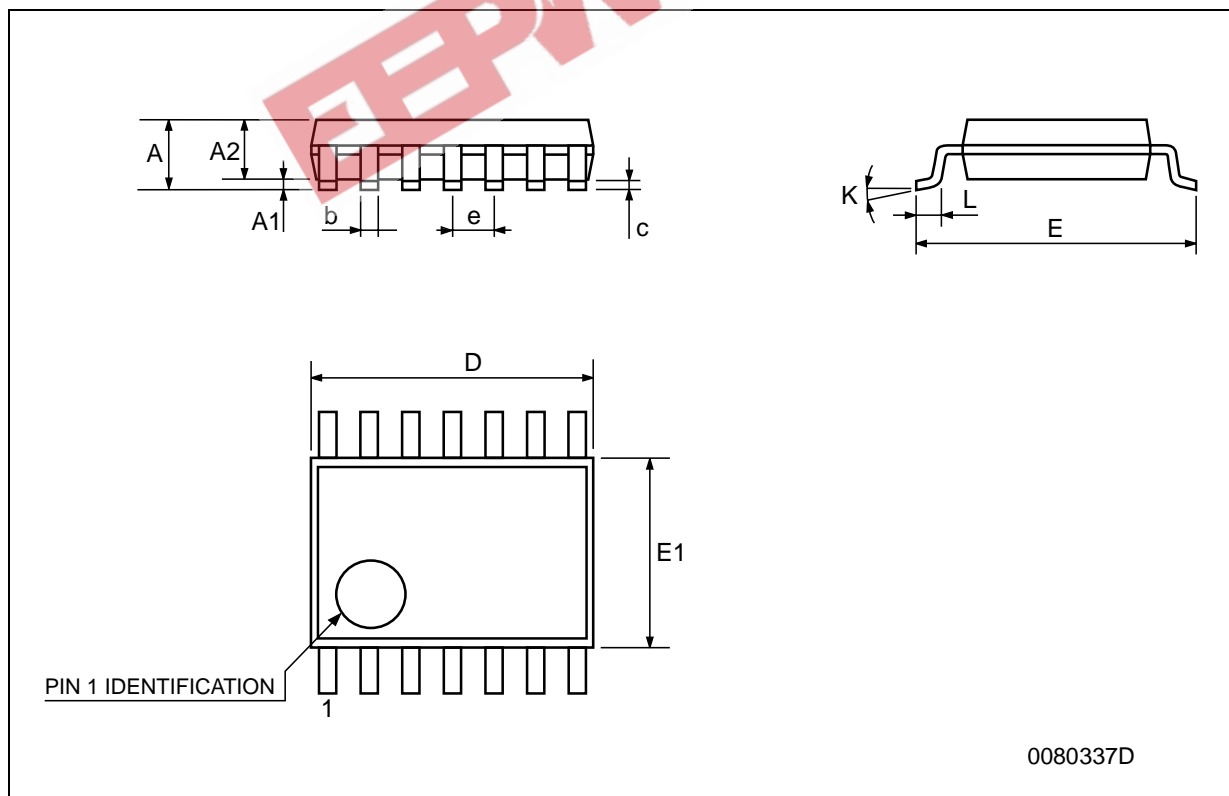
DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	1.35		1.75	0.053		0.069
A1	0.1		0.25	0.004		0.010
A2	1.10		1.65	0.043		0.065
B	0.33		0.51	0.013		0.020
C	0.19		0.25	0.007		0.010
D	8.55		8.75	0.337		0.344
E	3.8		4.0	0.150		0.157
e		1.27			0.050	
H	5.8		6.2	0.228		0.244
h	0.25		0.50	0.010		0.020
L	0.4		1.27	0.016		0.050
k	0°		8°	0°		8°
ddd			0.100			0.004





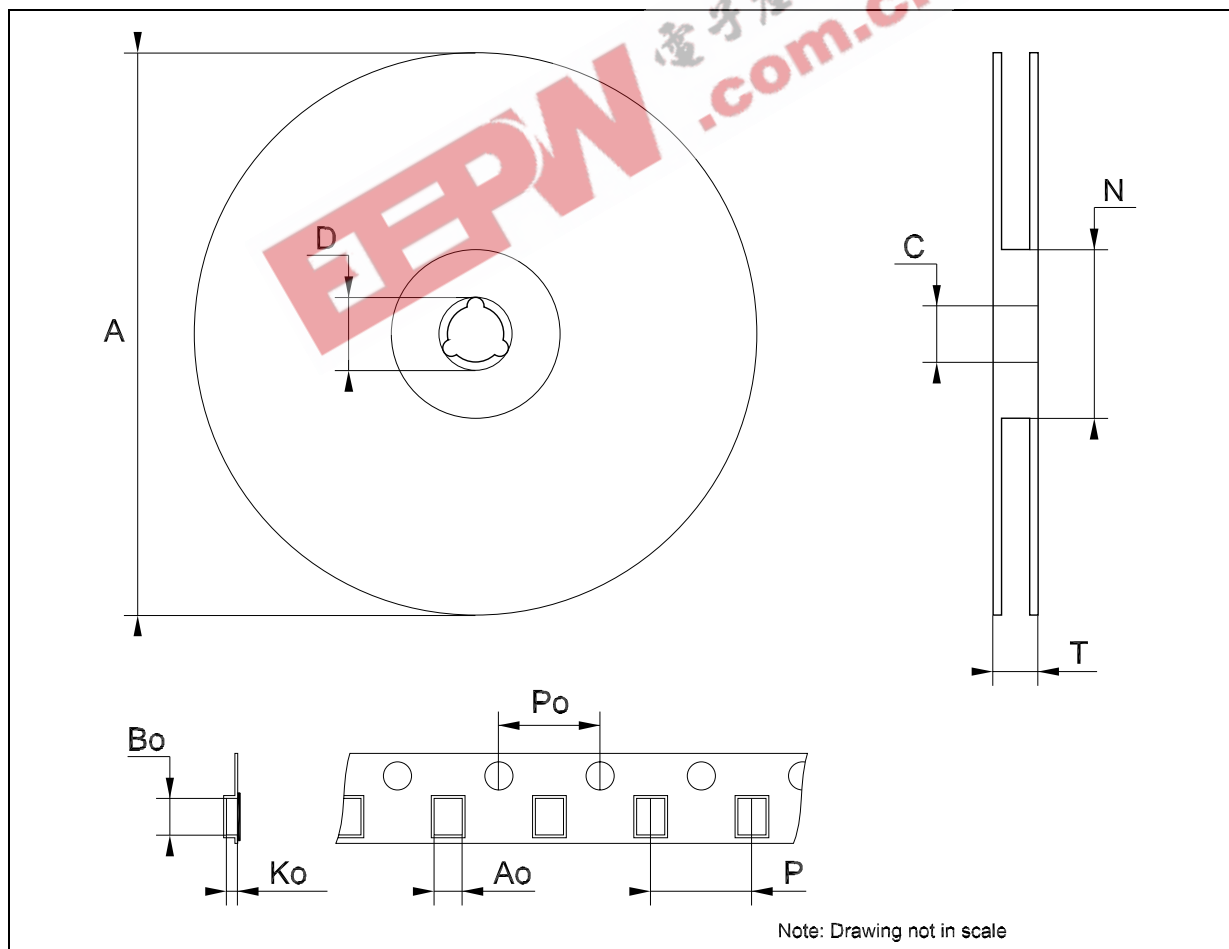
## TSSOP14 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.2			0.047
A1	0.05		0.15	0.002	0.004	0.006
A2	0.8	1	1.05	0.031	0.039	0.041
b	0.19		0.30	0.007		0.012
c	0.09		0.20	0.004		0.0089
D	4.9	5	5.1	0.193	0.197	0.201
E	6.2	6.4	6.6	0.244	0.252	0.260
E1	4.3	4.4	4.48	0.169	0.173	0.176
e		0.65 BSC			0.0256 BSC	
K	0°		8°	0°		8°
L	0.45	0.60	0.75	0.018	0.024	0.030



## Tape &amp; Reel SO-14 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A			330			12.992
C	12.8		13.2	0.504		0.519
D	20.2			0.795		
N	60			2.362		
T			22.4			0.882
Ao	6.4		6.6	0.252		0.260
Bo	9		9.2	0.354		0.362
Ko	2.1		2.3	0.082		0.090
Po	3.9		4.1	0.153		0.161
P	7.9		8.1	0.311		0.319



## Tape &amp; Reel TSSOP14 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A			330			12.992
C	12.8		13.2	0.504		0.519
D	20.2			0.795		
N	60			2.362		
T			22.4			0.882
Ao	6.7		6.9	0.264		0.272
Bo	5.3		5.5	0.209		0.217
Ko	1.6		1.8	0.063		0.071
Po	3.9		4.1	0.153		0.161
P	7.9		8.1	0.311		0.319

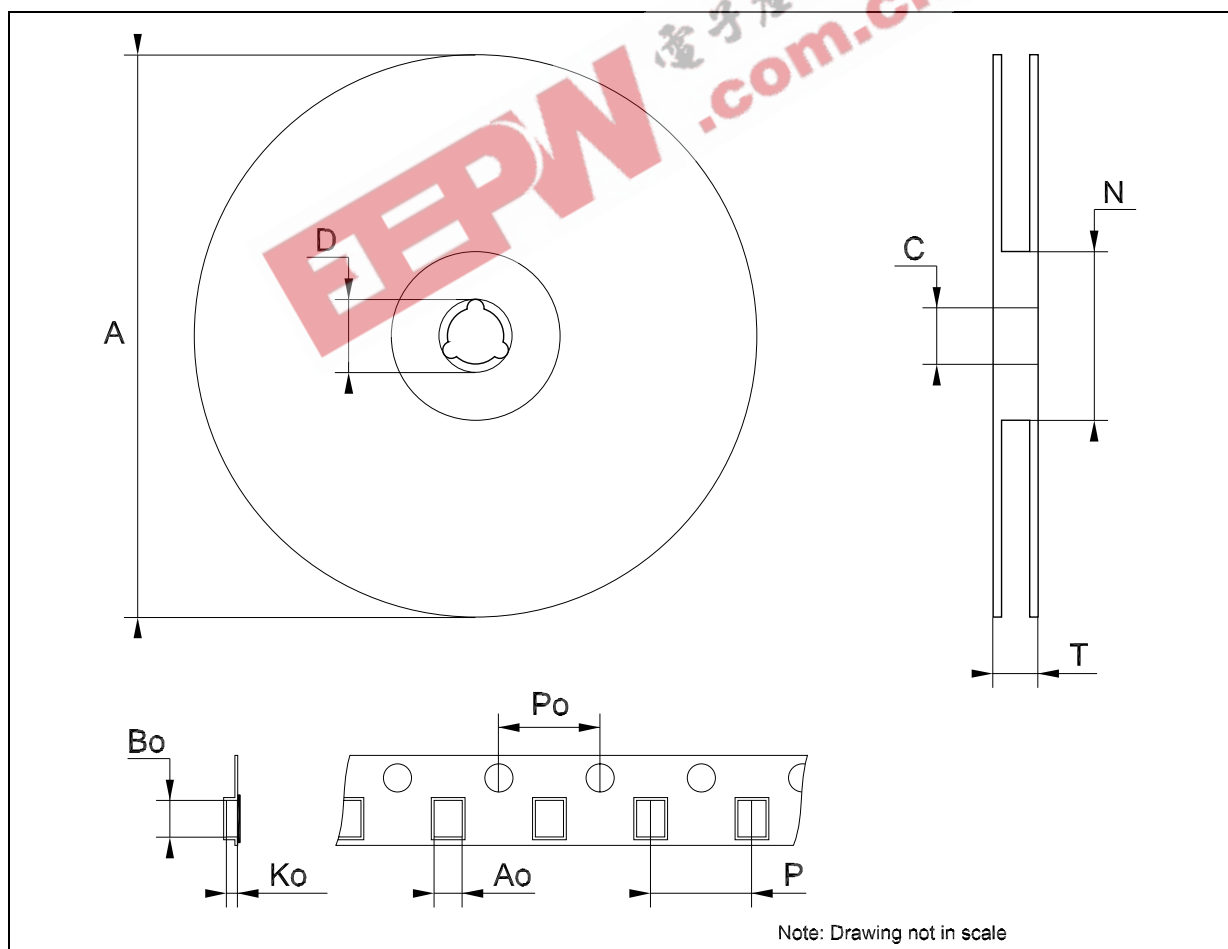


Table 10: Revision History

Date	Revision	Description of Changes
29-Jul-2004	5	Ordering Codes Revision - pag. 1.



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